Search Notes

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09/937,623

Art Unit

Examiner

Anand Bhatnagar

MATSUMOTO ET AL.

Applicant(s)/Patent under Reexamination

2623

| SEARCHED |           |          |          |  |  |  |
|----------|-----------|----------|----------|--|--|--|
| Class    | Subclass  | Date     | Examiner |  |  |  |
| 382      | 124,125   | 3/1/2006 | АВ       |  |  |  |
| 283      | 68        | 3/1/2006 | AB       |  |  |  |
| 356      | 71        | 3/1/2006 | AB       |  |  |  |
| 340      | 5.82,5.83 | 3/1/2006 | AB       |  |  |  |
| text     | see sheet | 3/1/2006 | AB       |  |  |  |
| updated  | see sheet | 3/1/2006 | AB       |  |  |  |
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| INTERFERENCE SEARCHED |          |               |  |  |  |  |
|-----------------------|----------|---------------|--|--|--|--|
| Subclass              | Date     | Examiner      |  |  |  |  |
|                       | 3/1/2006 |               |  |  |  |  |
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|                       |          |               |  |  |  |  |
|                       |          | Subclass Date |  |  |  |  |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY)  |          |      |  |  |
|---|----------|------|--|--|
|   | DATE     | EXMR |  |  |
| 382/100,115,124-<br>126;235/380,492;704/246,273;902/3,4<br>,25;340/5.1,5.2,5.82,5.83;283/68;356/<br>71;705/1,26,42;707/2,6,7;396/1w/tex | 3/1/2006 | AB   |  |  |
| IEEE  | 3/1/2006 | AB   |  |  |
| Inventor  | 3/1/2006 | AB   |  |  |
| Samir Ahmed; Discussed claim 10 and has not seen the limitation of shifting a line for fingerprint image and then comparing.            | 03/01/06 | AB . |  |  |
| Vikkram Bali; Discussed claim 10 and has not seen the limitation of shifting a line for fingerprint image for comparison.               | 3/1/2006 | AB   |  |  |
| Jingge Wu; allow the case   | 3/1/2006 | AB   |  |  |
| (imag\$4 and densit\$5 and line\$1 and<br>(shift\$4 mov\$5 slid\$4 offset\$7<br>displac\$7 relocat\$5 ) and compar\$4<br>and (noise\$1  | 03/01/06 | АВ   |  |  |
|   | ,        |      |  |  |